

**Search Notes**

Application/Control No.

10/665,316

Examiner

Jason M. Han

Applicant(s)/Patent under  
Reexamination

ALBOU ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	296-297	4/21/2006	JMH
362	299-300	4/21/2006	JMH
362	302	4/21/2006	JMH
362	307-309	4/21/2006	JMH
362	311	4/21/2006	JMH
362	326-328	4/21/2006	JMH
362	335-338	4/21/2006	JMH
362	339-341	4/21/2006	JMH
362	346	4/21/2006	JMH
362	507	4/21/2006	JMH
362	516-518	4/21/2006	JMH
362	520-522	4/21/2006	JMH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
EAST (US-PGPUB) - See Printout		4/21/2006	JMH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	4/21/2006	JMH